



P-Channel 200-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^a	Q _g (Typ.)	
- 200	1.61 at V _{GS} = - 10 V	- 0.95	8 nC	
- 200	1.65 at V _{GS} = - 6 V	- 0.93		

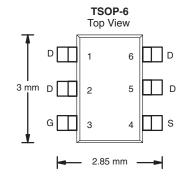
FEATURES

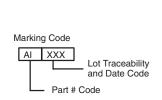
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

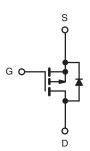


APPLICATIONS

· Active Clamp Circuits in DC/DC Power Supplies







Ordering Information: Si3475DV-T1-E3 (Lead (Pb)-free)

Si3475DV-T1-GE3 (Lead (Pb)-free and Halogen-free)

P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 200	V	
Gate-Source Voltage		V _{GS}	± 20	
	T _C = 25 °C		- 0.95 ^a	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1 , [- 0.77	
Continuous Diain Current (1) = 150 °C)	T _A = 25 °C	l _D	- 0.75 ^{b,c}	
	T _A = 70 °C		- 0.59 ^{b,c}	_
Pulsed Drain Current		I _{DM}	- 3	A
Continuous Source-Drain Diode Current	T _C = 25 °C	_	- 2.6	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.6 ^{b,c}	
Avalanche Current	1 0.411	I _{AS}	3	
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	0.45	mJ
	T _C = 25 °C		3.2	
Maximum Power Dissipation	T _C = 70 °C		2.1	14/
	T _A = 25 °C	P _D	2 ^{b,c}	w
	T _A = 70 °C		1.25 ^{b,c}	
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	51	62.5	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	32	39		

Notes:

- a. $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 110 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 200			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 240			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 250 μΑ		6.2		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 2		- 4	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zava Cata Valtaga Dusis Coursest	I _{DSS}	V _{DS} = - 200 V, V _{GS} = 0 V			- 1	μА	
Zero Gate Voltage Drain Current		V _{DS} = - 200 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 2			Α	
	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 0.9 A		1.34	1.61	Ω	
Drain-Source On-State Resistance ^a		V _{GS} = - 6 V, I _D = - 0.7 A		1.37	1.65		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 0.9 A		3.5		S	
Dynamic ^b							
Input Capacitance	C _{iss}			500		pF	
Output Capacitance	C _{oss}	$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		26			
Reverse Transfer Capacitance	C _{rss}			18			
Total Cata Charres	Q _g	$V_{DS} = -100 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -1 \text{ A}$		11.7	18	nC	
Total Gate Charge				7.8	12		
Gate-Source Charge		$V_{DS} = -100 \text{ V}, V_{GS} = -6 \text{ V}, I_{D} = -1 \text{ A}$		2			
Gate-Drain Charge	Q _{gd}			3.7			
Gate Resistance	R_{g}	f = 1 MHz		9	14	Ω	
Turn-On Delay Time	t _{d(on)}			9	14		
Rise Time	t _r	$V_{DD} = -100 \text{ V}, R_{L} = 100 \Omega$		11	18	<u></u>	
Turn-Off DelayTime		$I_D \cong$ - 1 A, V_{GEN} = - 10 V, R_g = 1 Ω		28	42		
Fall Time	t _f	_		12	18		
Turn-On Delay Time	On Delay Time t _{d(on)}			14	21	ns	
Rise Time	t _r	$V_{DD} = -100 \text{ V}, R_{L} = 100 \Omega$		29	44		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -1 \text{ A}, V_{GEN} = -6 \text{ V}, R_g = 1 \Omega$		23	35		
Fall Time	t _f			14	21		
Drain-Source Body Diode Characterist	ics						
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 0.95	Α	
Pulse Diode Forward Current	I _{SM}				- 3		
Body Diode Voltage	V _{SD}	I _S = - 1 A, V _{GS} = 0 V		- 0.81	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			84	130	ns	
Body Diode Reverse Recovery Charge	Q_{rr}	L = 12 A dl/dt = 100 A/v2 T = 25 °C		235	350	nC	
Reverse Recovery Fall Time	t _a	$I_F = -1.2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		46			
Reverse Recovery Rise Time	t _b			38		ns	

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

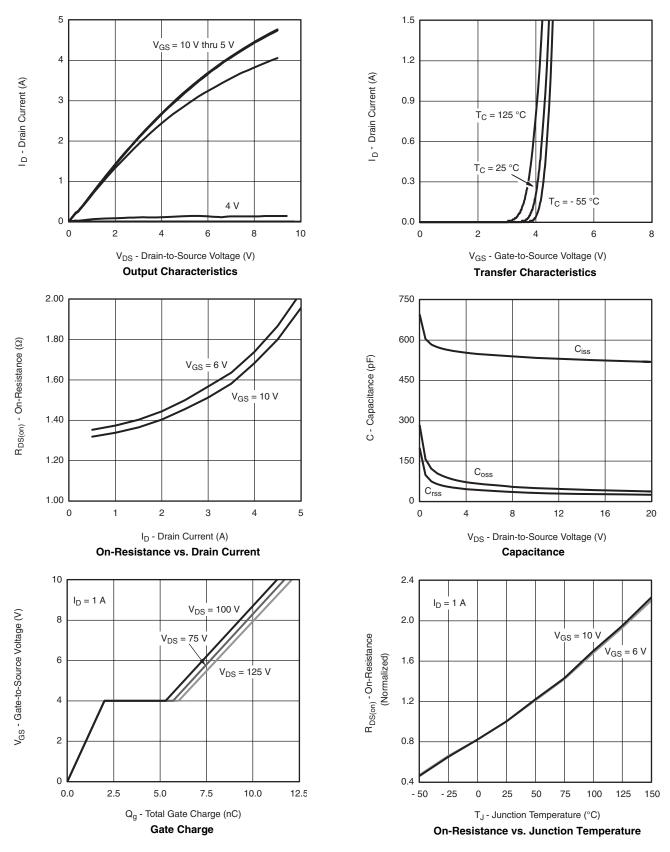
b. Guaranteed by design, not subject to production testing.



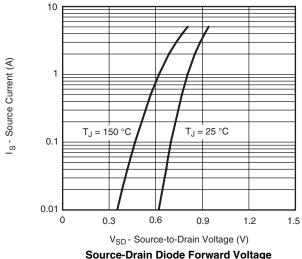


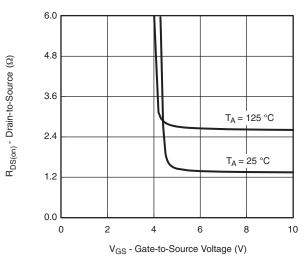


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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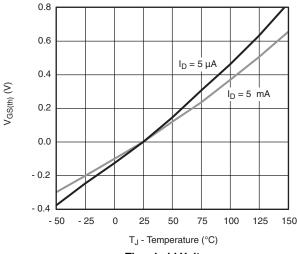


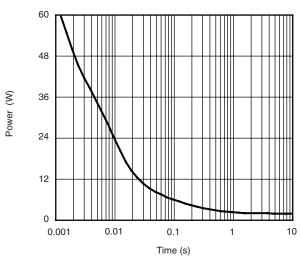


Source-Drain Diode Forward Voltage



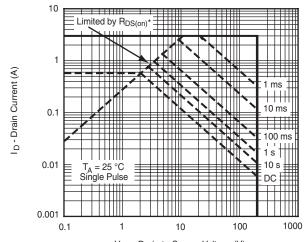
On-Resistance vs. Gate-to-Source Voltage





Threshold Voltage

Single Pulse Power, Junction-to-Ambient

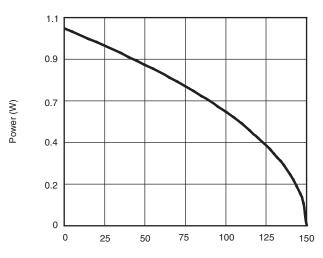


V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area

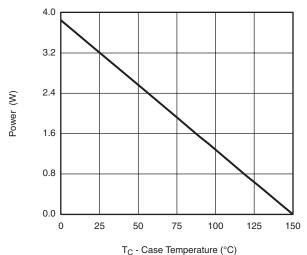


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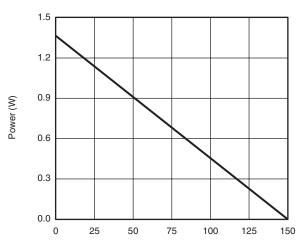


T_C - Case Temperature (°C)

Current Derating*



Power, Junction-to-Foot



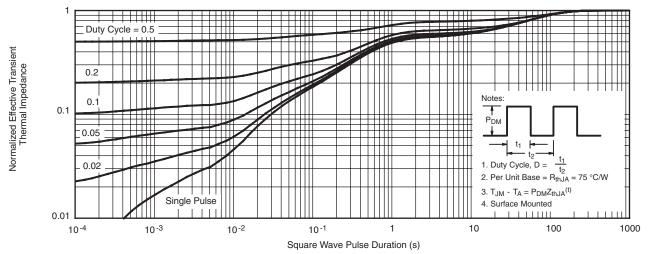
T_A - Ambient Temperature (°C)

Power Derating, Junction-to-Ambient

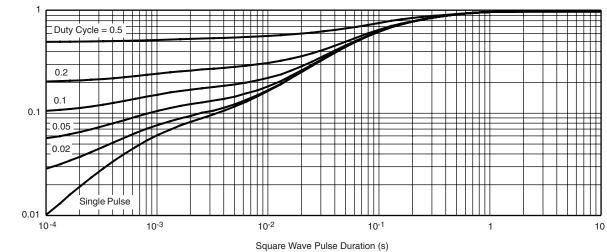
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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Normalized Effective Transient Thermal Impedance



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